

## Evaluation board for AEM30940

### Description

The AEM30940 evaluation board is a printed circuit board (PCB) featuring all the needed components to operate the AEM30940 integrated circuit (IC). Please refer to the datasheet for all the useful details about the AEM30940 (Document DS\_AEM30940).

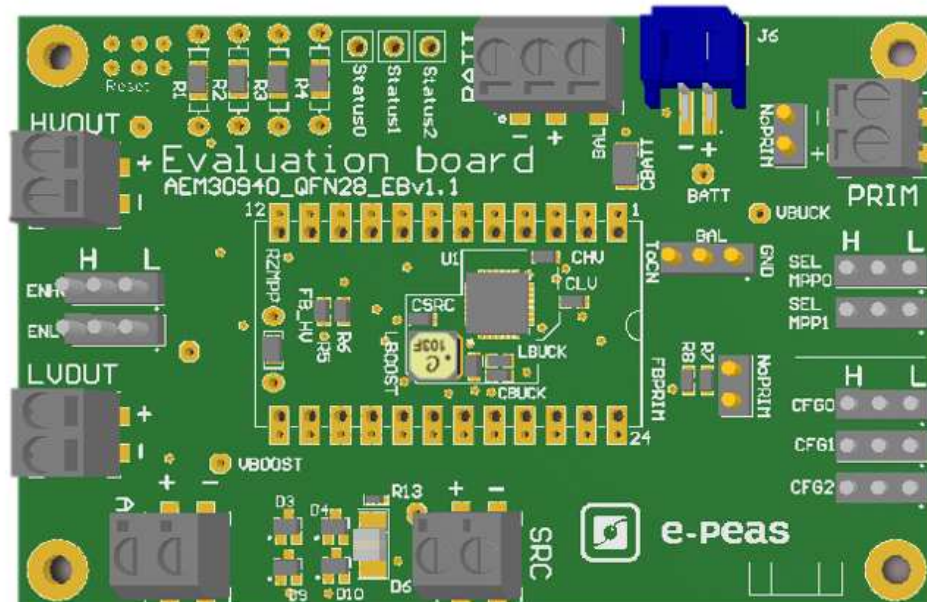
The AEM30940 evaluation board allows users to test the e-peas IC and analyze its performances in a laboratory-like setting. It allows easy connections to the energy harvester (DC or AC source), the storage element and the low-voltage and high-voltage loads and includes a rectifier for low frequency AC sources. It also provides all the configuration access to set the device in any one of the mode described in the datasheet. The control and status signals are available on standard pin headers, allowing users to wire for any usage scenario and evaluate the relevant performance.

The AEM30940 evaluation board is a plug and play, intuitive and efficient tool for making the appropriate decisions (component selection, operating modes) for the design of a highly efficient piezo or micro turbine powered subsystem in your target application.

### Applications

- Piezo harvesting
- Micro turbine harvesting
- Industrial monitoring
- Home automation
- Transportation
- Smart agriculture

### Appearance



### Features

#### Five two-way screw terminals

- Source of energy (DC)
- Source of energy (low frequency AC)
- Low-voltage load
- High-voltage load
- Primary energy storage element

#### One three-way screw terminal

- Energy storage element (battery or (super)capacitor)

#### One 2-pin "Shrouded Header"

- Alternative connection for the storage element

#### Eight 3-pin headers

- Maximum power point (MPP) configuration
- Low drop-out regulators (LDOs) enabling
- Energy storage elements and LDOs configuration
- Dual-cell supercapacitor configuration

#### Two 2-pin headers

- Primary battery configuration

#### Provision for nine resistors

- Custom mode configuration
- ZMPP configuration
- Primary battery configuration

#### Three 1-pin headers

- Access to status pins

### Device information

Part number	Dimensions
2AAEM30940C0010	76 mm x 50 mm

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# 1 Connections Diagram

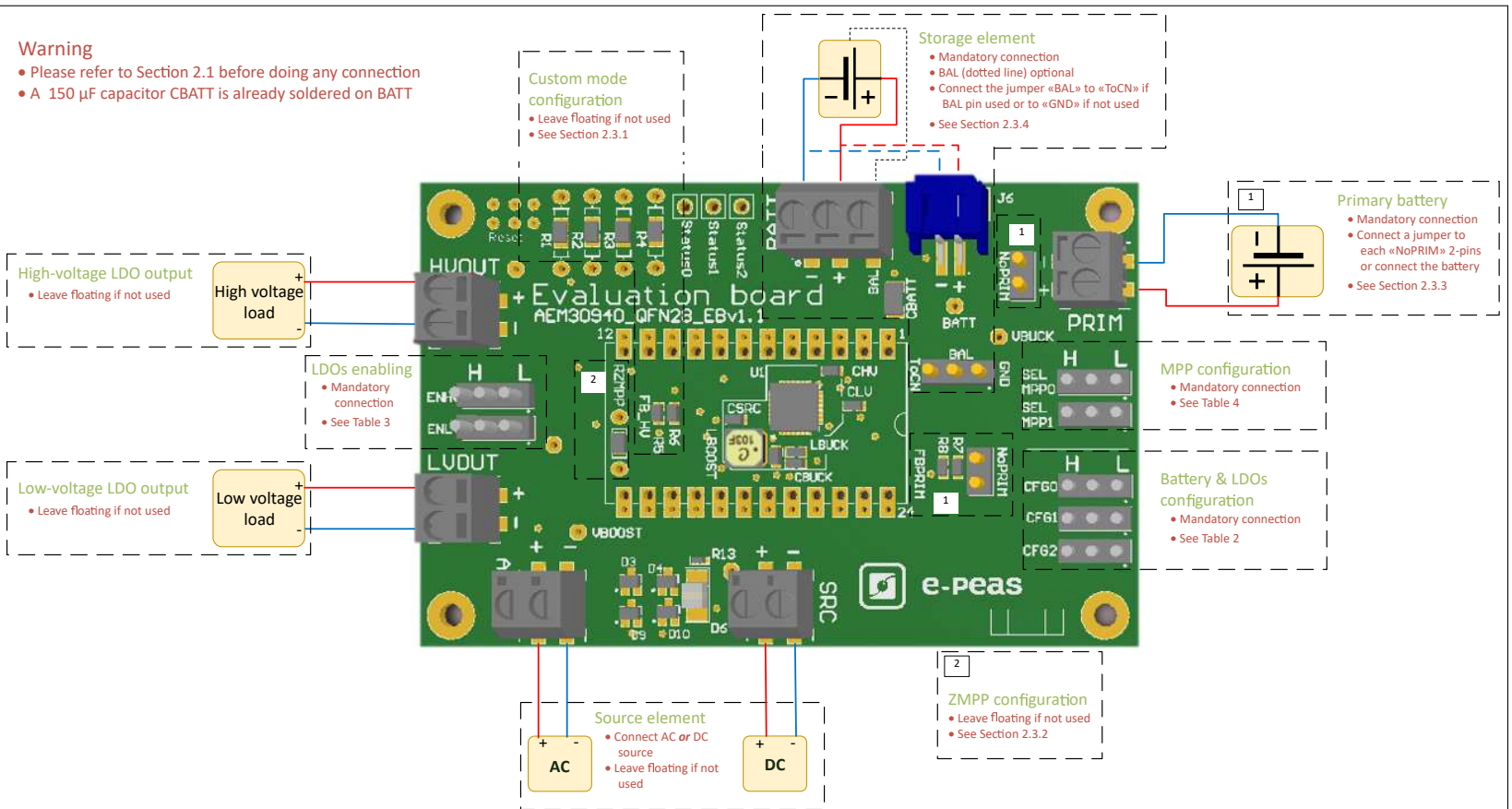


Figure 1: Connection diagram

## 1.1 Signals description

NAME		FUNCTION	CONNECTION	
Power signals			If used	If not used
LVOUT		Output of the low-voltage LDO regulator.	Connect a load.	
HVOUT		Output of the high-voltage LDO regulator.	Connect a load.	
BAL		Connection to mid-point of a dual-cell supercapacitor.	Connect mid-point and jumper BAL to "ToCN".	Connect jumper BAL to "GND".
BATT		Connection to the energy storage element.	Connect storage element in addition to CBATT (150 µF).	Do not remove CBATT.
PRIM		Connection to the primary battery.	Connect primary battery.	Connect a jumper to each NoPRIM 2-pins.
SRC		Connection to the DC harvested energy source. Output of the AC source rectifier.	Connect to the source element.	Leave floating.
AC SRC		Connection to the AC harvested energy source.	Connect to the source element.	Leave floating.
Debug signals				
VBOOST		Output of the boost converter.		
VBUCK		Output of the buck converter.		
Configuration signals				
CFG[2]		Configuration of the threshold voltages for the energy storage element and the output voltage of the LDOs.	Connect jumper (see Table 2).	Cannot be left floating (see Table 2).
CFG[1]				
CFG[0]				
SELMPP[1]		Configuration of the MPP ratio.	Connect jumper (see Table 4).	Cannot be left floating (see Table 4).
SELMPP[0]				
FB_PRIM		Configuration of the primary battery.	Use resistors R7-R8 (see Section 2.3.3).	Connect a jumper to each NoPRIM 2-pins.
FB_HV		Configuration of the high-voltage LDO in the custom mode.	Use resistors R5-R6 (see Section 2.3.1).	Leave floating.
RZMPP		Configuration of the constant impedance MPP.	Use resistor RZMPP (see Section 2.3.2).	Leave floating.
Control signals				
ENHV		Enabling pin for the high-voltage LDO.	Connect jumper (see Table 3).	Cannot be left floating (see Table 3).
ENLV		Enabling pin for the low-voltage LDO.	Connect jumper (see Table 3).	Cannot be left floating (see Table 3).
Status signals				
STATUS[2]		Logic output. Asserted when the AEM performs the MPP evaluation.		
STATUS[1]		Logic output. Asserted if the battery voltage falls under <i>Vovdis</i> or if the AEM is taking energy from the primary battery.		
STATUS[0]		Logic output. Asserted when the LDOs can be enabled.		

Table 1: Pin description

## 2 General Considerations

### 2.1 Safety information

Always connect the elements in the following order:

1. Reset the board - see "How to reset the AEM30940 evaluation board" on page 7.
2. Completely configure the PCB (jumpers/resistors);
  - MPP configuration (SELMPP[0], SELMPP[1] and RZMPP) - see Table 4,
  - Battery and LDOs configuration (CFG[0], CFG[1], CFG[2] and, if needed, R1-R2-R3-R4-R5-R6) - see Table 2,
  - Primary battery configuration (NoPRIM or R7-R8) - see Section 2.3.3,
  - LDOs enabling (ENHV and ENLV) - see Table 3,
  - Balun circuit connection (BAL) - see Section 2.3.4.
3. Connect the storage elements on BATT and optionally the primary battery on PRIM.
4. Connect the high and/or low voltage loads on HVOUT/LVOUT (optional).
5. Connect the source on AC or DC SRC. Do not use both simultaneously.

To avoid damage to the board, users are urged to follow this procedure.

### 2.2 Basic configurations

The MPP configuration is not available on the AEM30940 evaluation board. The MPP is by default configured to 50% of  $V_{oc}$  as this ratio optimize the proposed rectifier efficiency.

Configuration pins			Storage element threshold voltages			LDOs output voltages		Typical use	
CFG[2]	CFG[1]	CFG[0]	Vovch	Vchrdy	Vovdis	Vhv	Vlv		
H	H	H	4.12 V	3.67 V	3.60 V	3.3 V	1.8 V	Li-ion battery	
H	H	L	4.12 V	4.04 V	3.60 V	3.3 V	1.8 V	Solid state battery	
H	L	H	4.12 V	3.67 V	3.01 V	2.5 V	1.8 V	Li-ion/NiMH battery	
H	L	L	2.70 V	2.30 V	2.20 V	1.8 V	1.2 V	Single-cell (super) capacitor	
L	H	H	4.50 V	3.67 V	2.80 V	2.5 V	1.8 V	Dual-cell supercapacitor	
L	H	L	4.50 V	3.92 V	3.60 V	3.3 V	1.8 V	Dual-cell supercapacitor	
L	L	H	3.63 V	3.10 V	2.80 V	2.5 V	1.8 V	LiFePO4 battery	
L	L	L	Custom mode - see Section 2.3.1				1.8 V		

Table 2: Usage of CFG[2:0]

ENLV	ENHV	LV output	HV output
H	H	Enabled	Enabled
H	L	Enabled	Disabled
L	H	Disabled	Enabled
L	L	Disabled	Disabled

Table 3: LDOs enabling

SELMPP[1]	SELMPP[0]	Vmpp/Voc
L	L	50%
L	H	65%
H	L	80%
H	H	ZMPP

Table 4: Usage of SELMPP[1:0]

## 2.3 Advanced configurations

A complete description of the system constraints and configurations is available in Section 8 "System configuration" of the AEM30940 datasheet .

A reminder on how to compute the configuration resistors value is provided below. Calculation can be made with the help of the spreadsheet found at the [e-peas website](#).

### 2.3.1 Custom mode

In addition to the pre-defined protection levels, the custom mode allows users to define their own levels via resistors R1 to R4 and to tune the output of the high voltage LDO via resistors R5-R6.

By defining  $RT = R1+R2+R3+R4$  ( $1\text{ M}\Omega \leq RT \leq 100\text{ M}\Omega$ ):

- $R1 = RT (1\text{ V} / V_{ovch})$
- $R2 = RT (1\text{ V} / V_{chr dy} - 1\text{ V} / V_{ovch})$
- $R3 = RT (1\text{ V} / V_{ovdis} - 1\text{ V} / V_{chr dy})$
- $R4 = RT (1 - 1\text{ V} / V_{ovdis})$

By defining  $RV = R5+R6$  ( $1\text{ M}\Omega \leq RV \leq 40\text{ M}\Omega$ ):

- $R5 = RV (1\text{ V} / V_{hv})$
- $R6 = RV (1 - 1\text{ V} / V_{hv})$

Make sure the protection levels satisfy the following conditions:

- $V_{chr dy} + 0.05\text{ V} \leq V_{ovch} \leq 4.5\text{ V}$
- $V_{ovdis} + 0.05\text{ V} \leq V_{chr dy} \leq V_{ovch} - 0.05\text{ V}$
- $2.2\text{ V} \leq V_{ovdis}$

- $V_{hv} \leq V_{ovdis} - 0.3\text{ V}$

If unused, leave the resistor footprints (R1 to R6) empty.

### 2.3.2 ZMPP configuration

If this configuration is chosen (see Table 4), the AEM30940 regulate  $V_{src}$  at a voltage equals to the product of R1 times the current available at the output of the internal rectifier.

- $10\ \Omega \leq RZMPP \leq 1\text{ M}\Omega$

If unused, leave the resistor footprint R1 empty.

### 2.3.3 Primary battery configuration

As to the main storage element, the primary battery protection levels have to be defined. To do so, use resistors R7-R8.

By defining  $RP = R7+R8$  ( $100\text{ k}\Omega \leq RP \leq 500\text{ k}\Omega$ ):

- $R7 = (\frac{V_{prim\_min}}{4} * RP) / 2.2\text{ V}$
- $R8 = RP - R7$

If unused, connect a jumper to each "NoPRIM" 2-pins.

### 2.3.4 Balun circuit configuration

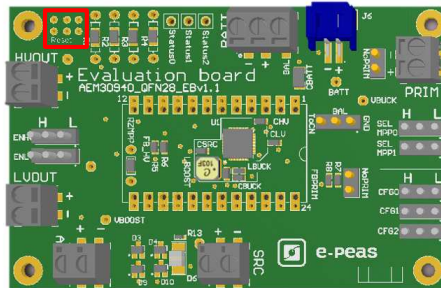
When using a dual-cell supercapacitor (that does not already include a balancing circuit), enable the balun circuit configuration to ensure equal voltage on both cells. To do so:

- Connect the node between the two supercapacitor cells to BAL (on BATT connector)
- Use a jumper to connect "BAL" to "ToCN"

If unused, use a jumper to connect "BAL" to "GND".

### How to reset the AEM30940 evaluation board:

To reset the board, simply **disconnect the storage device and the optional primary battery** and connect the 6 "Reset" connections (working from the rightmost to the left) to a GND node (i.e. the negative pin of any connector) in order to discharge the internal nodes of the system.



## 3 Functional Tests

This section presents a few simple tests that allow the user to understand the functional behavior of the AEM30940. **To avoid damaging the board, follow the procedure found in Section 2.1 "Safety information"**. If a test has to be restarted, make sure to properly reset the system to obtain reproducible results.

The following functional tests were made using the following setup:

- Configuration: **SELMPP[1:0] = HL**, **CFG[2:0] = HLL**, **ENLV = H**, **ENHV = H**
- Storage element: capacitor (4.7 mF + CBATT)
- Load: 10 kΩ on **HVOUT**, **LVOUT** floating
- **SRC**: current source (1 mA or 100 μA) with voltage compliance (4 V)

Feel free to adapt the setup to match your system as long as you respect the input and cold-start constraints (see Section 1 "Introduction" of AEM30940 datasheet).

### 3.1 Start-up

The following example allows users to observe the behavior of the AEM30940 in the wake-up mode.

#### Setup

1. Place the probes on the nodes to be observed.
2. Referring to Figure 1, follow steps 1 to 5 explained in Section 2.1.

#### Observations and measurements

- **BATT**: Voltage rises as the power provided by the source is transferred to the storage element (see Figure 2).
- **HLDO/LLDO**: Regulated when voltage on **BATT** first rises above **Vchrdy** (see Figure 2).
- **STATUS[0]**: Asserted when the LDOs are ready to be enabled (refer to Section 7.2 "Normal mode" of the AEM30940 datasheet) (see Figure 2).

- **STATUS[2]**: Asserted each time the AEM30940 performs a MPP evaluation (see Figure 3).

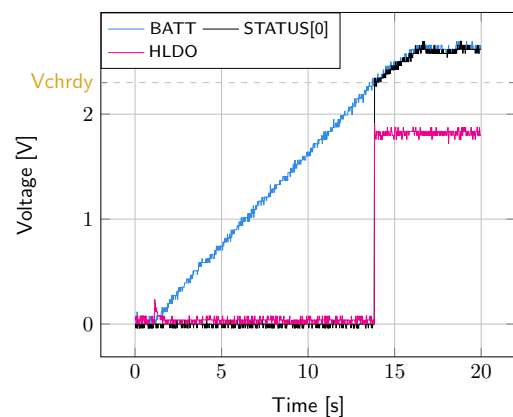


Figure 2: **STATUS[0]** and **HLDO** evolution with **BATT**

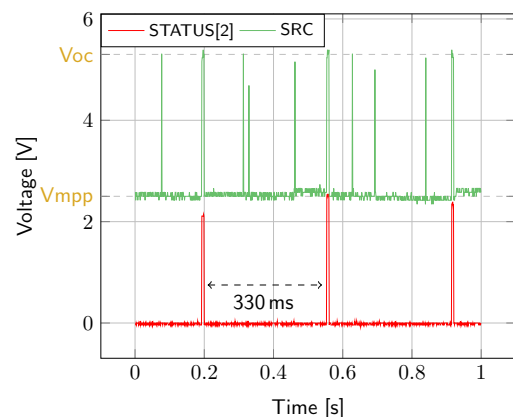


Figure 3: **SRC** and **STATUS[2]** while energy is extracted from **SRC** (**BATT** under **Vovch**)

### 3.2 Shutdown

This test allows users to observe the behavior of the AEM30940 when the system is running out of energy.



### Setup

1. Place the probes on the nodes to be observed.
2. Referring to Figure 1, follow steps 1 to 5 explained in Section 2.1. Configure the board in the desired state and start the system (see Section 3.1). Do not use a primary battery.
3. Let the system reach a steady state (i.e. voltage on **BATT** between **Vchrdy** and **Vovch** and **STATUS[0]** asserted).
4. Remove your source element and let the system discharge through quiescent current and **HVOUT/LVOUT** load(s).

### Observations and measurements

- **BATT**: Voltage decreases as the system consumes the power accumulated in the storage element. The voltage remains stable after crossing **Vovdis** (see Figure 4).
- **STATUS[0]**: De-asserted when the LDOs are no longer available as the storage element is running out of energy. This happens 600 ms after **STATUS[1]** assertion (see Figure 4).
- **STATUS[1]**: Asserted for 600 ms when the storage element voltage (**BATT**) falls below **Vovdis** (see Figure 4).

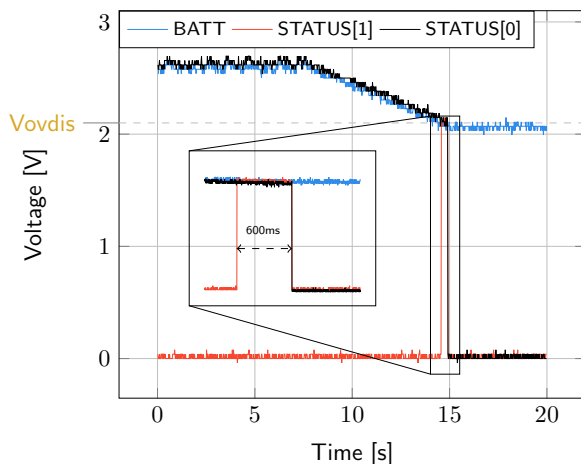


Figure 4: LDOs disabled around 600 ms after **BATT** reaches **Vovdis**

### 3.3 Switching on primary battery

This example allows users to observe switching from the main storage element to the primary battery when the system is running out of energy.

#### Setup

1. Place the probes on the nodes to be observed.
2. Referring to Figure 1, follow steps 1 to 5 explained in Section 2.1. Configure the board in the desired state and start the system (see Section 3.1). Connect a primary battery (example: 3.1V coin cell with protection level at 2.4V,  $R7 = 68\text{ k}\Omega$  and  $R8 = 180\text{ k}\Omega$ ).

3. Let the system reach a steady state (i.e. voltage on **BATT** between **Vchrdy** and **Vovch** and **STATUS[0]** asserted).
4. Remove your source element and let the system discharge through quiescent current and **HVOUT/LVOUT** load(s).

### Observations and measurements

- **BATT**: Voltage decreases as the system consumes the power accumulated in the storage element. The voltage reaches **Vovdis** and then rises again to **Vchrdy** as it is recharged from the primary battery (see Figure 5).
- **STATUS[0]**: Never de-asserted as the LDOs are still functional (see Figure 5).
- **HLDO**: Stable and not affected by switching on the primary battery (see Figure 5).

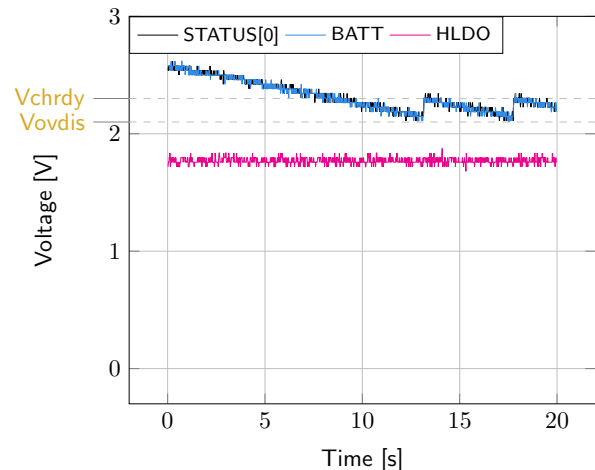


Figure 5: Switching from **SRC** to the primary battery

### 3.4 Cold start

The following test allows users to observe the minimum voltage required to coldstart the AEM30940. Be careful to avoid probing any unnecessary node to avoid leakage current induced by the probe. Make sure to properly reset the board to observe the cold-start behavior.

#### Setup

1. Place the probes on the nodes to be observed.
2. Referring Figure 1, follow steps 1 and 2 explained in Section 2.1. Configure the board in the desired state. Do not plug any storage element in addition to CBATT.
3. **SRC**: Connect your source element.



### Observation and measurements

- **SRC**: Equal to the cold-start voltage during the cold-start phase. Regulated at the selected MPPT percentage of  $V_{oc}$  when cold start is over (see Figure 6). Be careful that the cold-start phase time will shorten with the input power. Limit it to ease the observation.
- **BATT**: Starts to charge when the cold-start phase is over (see Figure 6).

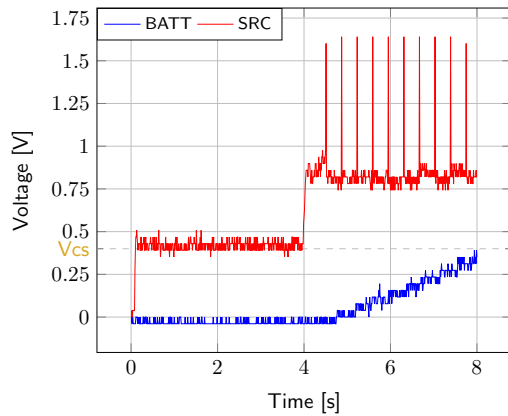


Figure 6: AEM30940 behaviour during cold start

### 3.5 Dual-cell supercapacitor balancing circuit

This test allows users to observe the balancing circuit behavior that maintains the voltage on BAL equilibrated.

#### Setup

1. Following steps 1 and 2 explained in Section 2.1 and referring to Figure 1, configure the board in the desired state. Plug the jumper linking "BAL" to "ToCN".
2. **BATT**: Plug capacitor C1 between the positive (+) and the BAL pins and a capacitor C2 between BAL and the negative (-) pins.  
Select  $C1 \neq C2$  such that:
  - $C1 \ \& \ C2 > 1 \text{ mF}$
  - $\frac{C2 * V_{chrdy}}{C1} \geq 0.9 \text{ V}$
3. **SRC**: Plug your source element to start the flow of power to the system.

#### Measurements

- **BAL**: Equal to half the voltage on **BATT**.

**Warning regarding measurements:**

Any item connected to the PCB (load, probe, storage device, etc.) involves a leakage current. This can negatively impact the measurements. Whenever possible, disconnect unused items to limit this effect.

## 4 Performance Tests

This section presents the tests to reproduce the performance graphs found in the AEM30940 datasheet and to understand the functionalities of the AEM30940. To be able to reproduce those tests, you will need the following:

- 1 voltage source
- 2 source measure units (SMUs)
- 1 oscilloscope

To avoid damaging the board, follow the procedure found in Section 2.1 "Safety information". If a test has to be restarted, make sure to properly reset the system to obtain reproducible results (see "How to reset the AEM30940 evaluation board" on page 7).

### 4.1 LDOs

The following example instructs users on how to measure the output voltage stability of the LDOs (Figure 16 and Figure 17 of AEM30940 datasheet).

**Setup**

1. Referring to Figure 1, follow steps 1 and 2 explained in Section 2.1. Configure the board in the desired state and plug your storage element(s).
2. **VBOOST**: Connect SMU1. Configure it to source voltage with a current compliance of 200 mA.
3. **HVOUT / LVOUT**: Connect SMU2 to the LDO you want to measure. Configure it to sink current with a voltage compliance of 5 V for **HVOUT** or 2.5 V for **LVOUT**.

**Manipulations**

1. Impose a voltage between **Vovch** and 5 V on SMU1 to force the AEM to start.
2. Sweep voltage on SMU1 from **Vovdis + 50 mV** to 4.5 V.
3. Repeat with different current levels on SMU2 (from 10  $\mu$ A to 80 mA for HVOUT and from 10  $\mu$ A to 20 mA for LVOUT).

**Measurements**

- **HVOUT/LVOUT**: Measure the voltage.

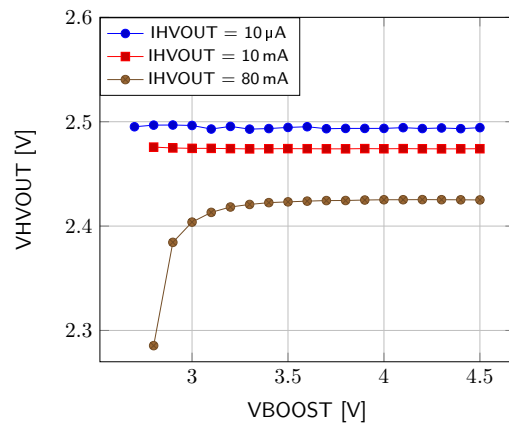


Figure 7: HVOUT at 2.5V

### 4.2 BOOST efficiency

This test allows users to reproduce the efficiency graphs of the boost converter (Figure 14 of AEM30940 datasheet).

**Setup**

1. Following steps 1 and 2 explained in Section 2.1 and referring to Figure 1, configure the board in the desired state.
2. **VBUCK**: Connect a 2.3V voltage source to prevent **VBUCK** to sink from **VBOOST**.
3. **SRC**: Connect SMU1. Configure it to source current with a voltage compliance of 0 V.
4. **VBOOST**: Connect SMU2. Configure it to source voltage with a current compliance of 200 mA.
5. **STATUS[2]**: Connect to one of the SMUs to detect falling edge.

**Manipulations**

1. Impose a voltage between **Vchrdy** and 5 V on SMU2 to force the AEM to start. When done, impose a voltage between **Vovdis + 50 mV** and **Vovch**.
2. Sweep voltage compliance on SMU1 from 50 mV to 5 V.
3. Repeat with different current levels on SMU1 (from 100  $\mu$ A to 100 mA) and with different voltage levels on SMU2 (from **Vovdis + 50 mV** to **Vovch**).

**Measurements**

- **STATUS[2]**: Do not make any measurements while high (boost converter is not active during MPP calculation).
- **SRC**: Measure the current and the voltage.